

## EAST Search History

| Ref # | Hits | Search Query   | DBs   | Default Operator | Plurals | Time Stamp       |
|-------|------|--|---|------------------|---------|------------------|
| L1    | 6    | PROBE WITH PIN AND SERIEs AND COMPONENT and bias\$3 AND SLEEVE AND SIGNAL AND SERIAL\$3.CLM. | US-PGPUB;<br>USPAT;<br>USOCR;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | OR               | OFF     | 2007/03/30 17:42 |
| L2    | 2615 | "probe pin"  | US-PGPUB;<br>USPAT;<br>USOCR;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | OR               | OFF     | 2007/03/30 17:43 |
| L3    | 81   | L2 and component and sleeve  | US-PGPUB;<br>USPAT;<br>USOCR;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | OR               | ON      | 2007/03/30 17:43 |
| L4    | 1    | "439"/219,700,169,428.ccls. and PROBE WITH PIN AND SERIAL\$3 AND COMPONENT and bias\$3       | US-PGPUB;<br>USPAT;<br>USOCR;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | OR               | OFF     | 2007/03/30 17:44 |
| L5    | 37   | "324"/\$.ccls. and PROBE WITH PIN AND SERIAL\$3 AND COMPONENT and bias\$3                    | US-PGPUB;<br>USPAT;<br>USOCR;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | OR               | OFF     | 2007/03/30 17:44 |